

<b>Notice of References Cited</b>	Application/Control No. 10/041,669	Applicant(s)/Patent Under Reexamination FUJIOKA, SATOSHI	
	Examiner Huan H. Tran	Art Unit 2861	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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